

Vishay Siliconix

N-Channel 30 V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
30	0.0055 at V _{GS} = 10 V	25	13.8 nC		
	0.0076 at $V_{GS} = 4.5 \text{ V}$	21	13.0110		

SO-8 S 1 S 2 T D S 3 G 4 SO-8

Top View

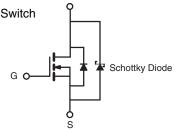
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- SkyFET[®] Monolithic TrenchFET[®] Power MOSFET and Schottky Diode
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Notebook PC
 - System Power
- VRM, POL, Server
- Synchronous Rectifier Switch



N-Channel MOSFET

Ordering Information: Si4752DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30			
Gate-Source Voltage	V _{GS}	± 20	V		
	T _C = 25 °C		25		
Continuous Drain Current /T 150 °C)	T _C = 70 °C	, [20		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	17.4 ^{b, c}		
	T _A = 70 °C		13.8 ^{b, c}		
Pulsed Drain Current (300 μs)		I _{DM}	80	A	
Continuous Source-Drain Diode Current	T _C = 25 °C		5.6		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.7 ^{b, c}		
Single Pulse Avalanche Current		I _{AS}	20	İ	
Single Pulse Avalanche Energy L = 0.1		E _{AS}	20	mJ	
	T _C = 25 °C		6.25		
Maximum Power Dissipation	T _C = 70 °C	P _D	4.0	W	
Maximum Power Dissipation	T _A = 25 °C		3.0 ^{b, c}		
	T _A = 70 °C		1.9 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	33	42	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	16	20	O/ VV	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 85 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-					
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			V
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	1.0		2.2	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V		0.018	0.15	- mA
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 100 °C		2.0	20	
On -State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A		0.0045	0.0055	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		0.0063	0.0076	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		45		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1700		pF
Output Capacitance	C _{oss}			410		
Reverse Transfer Capacitance	C _{rss}	1		130		
Total Gate Charge	Q _g	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		28.5	43	nC
Total date onlinge				13.8	21	
Gate-Source Charge	Q_gs	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		4.2		
Gate-Drain Charge	Q_gd			3.8		
Gate Resistance	R_g	f = 1 MHz	0.3	1.4	2.8	Ω
Turn-On Delay Time	t _{d(on)}			18	35	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		15	30	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		25	50	
Fall Time	t _f	1		8	16	
Turn-On Delay Time	t _{d(on)}			11	22	ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		12	24	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		25	50	
Fall Time	t _f	1		8	16	
Drain-Source Body Diode and Schottky	Characterist	tics				
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.6	Λ
Pulse Diode Forward Current ^a	I _{SM}				80	Α
Body Diode Voltage	V_{SD}	I _S = 3 A		0.46	0.65	V
Body Diode Reverse Recovery Time	t _{rr}			23	45	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C -		12	24	nC
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ C}$		11		ns
Reverse Recovery Rise Time	t _b			12		

Notes:

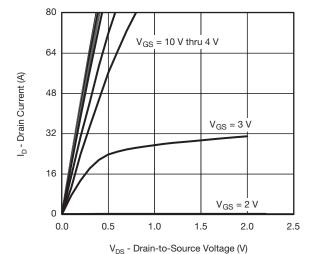
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

 $Stresses\ beyond\ those\ listed\ under\ "Absolute\ Maximum\ Ratings"\ may\ cause\ permanent\ damage\ to\ the\ device.\ These\ are\ stress\ ratings\ only,\ and\ functional\ operation$ of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



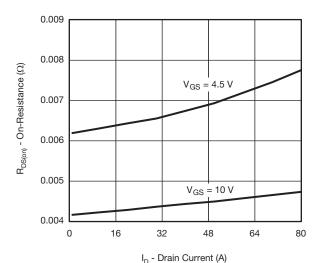
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

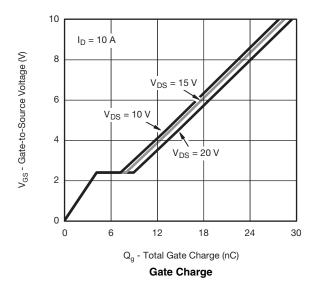


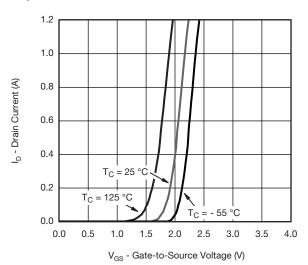
DS 2.a... to obtained foliage (1

Output Characteristics

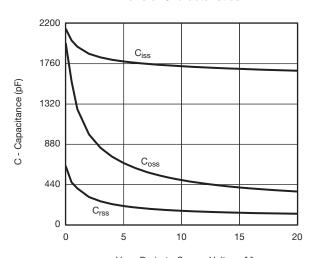


On-Resistance vs. Drain Current



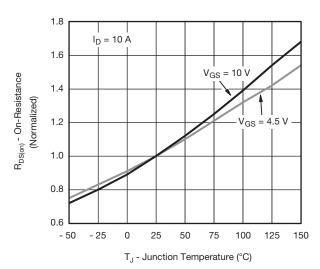


Transfer Characteristics



 $\rm V_{\rm DS}$ - Drain-to-Source Voltage (V)

Capacitance



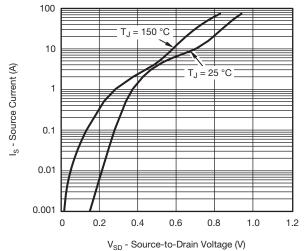
On-Resistance vs. Junction Temperature

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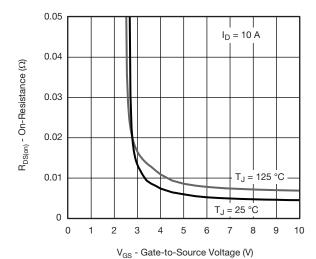
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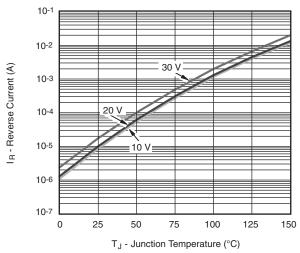
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



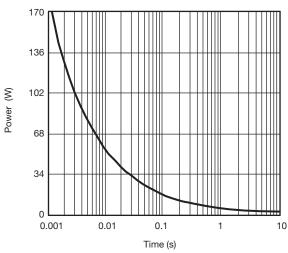
Source-Drain Diode Forward Voltage



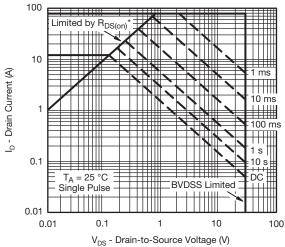
On-Resistance vs. Gate-to-Source Voltage



Reverse Current (Schottky)



Single Pulse Power, Junction-to-Ambient



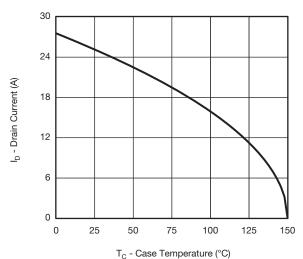
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area



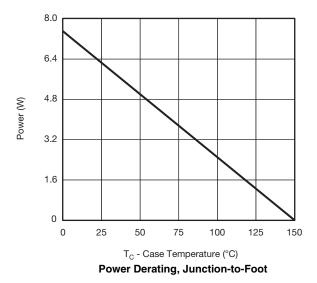
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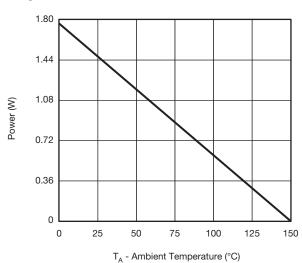
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



To Gado Tomporataro (

Current Derating*





Power Derating, Junction-to-Ambient

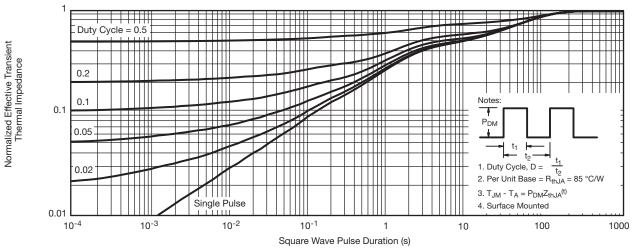
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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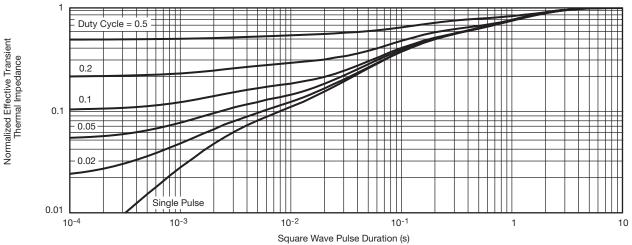
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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